## Application/Control No. Applicant(s)/Patent Under Notice of References Cited 10/827,201 Reexamination LITTRELL, NATHAN BOWMAN Examiner Art Unit Marc Duncan

Page 1 of 1 2113

U.S.	PATENT	DOCUMENTS

*	T	Document Number	T	U.S. PATENT DOCUMENTS		
	<u> </u>	Country Code-Number-Kind Code	Date MM-YYYY	Name	<del></del>	<u></u>
*	Α	US-2007/0050684	03-2007	<del></del>		Classification
*	В	US-7,030,746	04-2006	Takaoka et al.		714/047
*	С	US-2002/0044325	04-2002	Littrell et al.		340/500
	۵	US-	04-2002	Noguti, Hidemi		359/189
	E	US-				
	F	US-				
	G	US-				
	Н	US-				
		US-				
	J	US-				
$\bot$	к	US-		<del></del>		
$\perp$	L	US-	<del></del>			
	М	US-	<del></del>			
т-		Daniel	FC	REIGN PATENT DOCUMENTS		

## FOREIGN PATENT DOCUMENTS

*		Document Number	FO	REIGN PATENT DOCUM	WENTS	
		Country Code-Number-Kind Code	Date MM-YYYY	Country		
	N				Name	Classification
	0		<del> </del>			
	Р					
	Q					
	R					
	s					
$\prod$	Т					
*				ON-PATENT DOCUMEN	Te	

*	т	NON-PATENT DOCUMENTS
	<del> </del>	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	of California ages)
	v	
	w	
+		
	×	
	^	
copy ites in	of this	reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYYY format are publication dates. Classifications may be US or foreign.